

Innovating Energy Technology

http://www.fujielectric.com/products/semiconductor/ **FUJI POWER MOSFET**

Super J MOS[®] S2 series

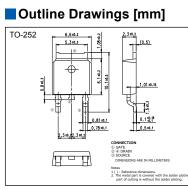
N-Channel enhancement mode power MOSFET

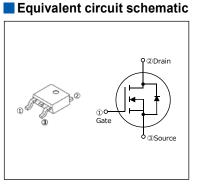
Features

Pb-free lead terminal **RoHS** compliant uses Halogen-free molding compound

Applications

For switching





Absolute Maximum Ratings at Tc=25°C (unless otherwise specified)

Parameter	Symbol	Characteristics	Unit	Remarks
Drain Course Voltone	VDS	600	V	
Drain-Source Voltage	VDSX	600	V	V _{GS} =-30V
Continuous Drain Current		10.4	А	Tc=25°C Note*1
Continuous Drain Current	ID	6.6	А	Tc=100°C Note*1
Pulsed Drain Current	IDP	31.2	А	Note *1
Gate-Source Voltage	V _{GS}	±30	V	
Non-Repetitive Maximum Avalanche Current	las	1.5	А	Note *2
Non-Repetitive Maximum Avalanche Energy	Eas	468	mJ	Note *3
Maximum Drain-Source dV/dt	dV _{DS} /dt	50	V/ns	V _{DS} ≤ 600V
Continuous		10.4	А	Tc=25°C Note*1
Diode Forward Current	Isd	6.6	А	Tc=100°C Note*1
Pulsed Diode Forward Current	ISDP	31.2	А	Note *1
Peak Diode Recovery dV/dt	dV/dt	15	V/ns	Note *4
Peak Diode Recovery -di/dt	-di/dt	100	A/µs	Note *5
Maximum Rower Discinction	Po	75	W	T₂=25°C
Maximum Power Dissipation	PD	150	vv	T₀=25°C
Operating and Storage Temperature repre-	Tch	-55 to +150	°C	
Operating and Storage Temperature range	T _{stg}	-55 to +150	°C	

Note *1 : Limited by maximum channel temperature.

Note *2 : Tch≤150°Ć, See Fig.1 and Fig.2 Note *3 : Starting Tch=25°C, I_{AS}=0.9A, L=1.06H, V_{DD}=60V, R_G=50Ω, See Fig.1 and Fig.2

Eas limited by maximum channel temperature and avalanche current. Note *4 : Iso≤10.4A, -di/dt≤100A/µs, Vos peak≤600V, Tch≤150°C. Note *5 : Iso≤10.4A, dV/dt≤15V/ns, Vos peak≤600V, Tch≤150°C.

Electrical Characteristics at Tc=25°C (unless otherwise specified) Static Ratings

Parameter	Symbol	Conditions		Min.	Тур.	Max.	Unit
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I₀=250µA		600	-	-	V
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} I₀=150µA		2.5	3.0	3.5	V
Zero Gate Voltage Drain Current	loss	V _{DS} =600V V _{GS} =0V	T _{ch} =25°C	-	-	25	-μA
		V _{DS} =480V V _{GS} =0V	T _{ch} =125°C	-	-	250	
Gate-Source Leakage Current	Igss	V _{DS} =0V V _{GS} = ± 30V		-	10	100	nA
Drain-Source On-State Resistance	R _{DS(on)}	V _{ss} =10V I₀=5.2A		-	0.248	0.280	Ω
Gate resistance	RG	f=1MHz, open drain		-	12.7	-	Ω

Dynamic Ratings

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
Forward Transconductance	g fs	V _{DS} =25V I _D =5.2A	4.8	9.5	-	S
Input Capacitance	Ciss	V _{DS} =400V	-	790	-	
Output Capacitance	Coss	V _{GS} =0V	-	22	-	
Reverse Transfer Capacitance	Crss	f=250kHz	-	3.5	-	
Effective output capacitance, energy related (Note *6)	C _{o(er)}	V _{DS} =0400V V _{GS} =0V	-	53	-	pF
Effective output capacitance, time related (Note *7)	Co(tr)	V₀s=0400V V₀s=0V I₀=constant	-	183	-	
t _{d(on)}	t _{d(on)}	$ V_{DD}=400V, V_{GS}=10V I_{D}=5.2A, R_{G}=18Ω See Fig.3 and Fig.4 $	-	15	-	- ns
Turn-On Time	tr		-	28	-	
Turn-Off Time tr	t _{d(off)}		-	95	-	
	tr		-	21	-	
Total Gate Charge	QG		-	33	-	nC
Gate-Source Charge	Q _{GS}	V _{DD} =400V, V _{GS} =10V	-	11	-	
Gate-Drain Charge	QGD	— I₀=10.4A See Fig.5	-	9	-	
Drain-Source crossover Charge	Qsw		-	7	-	

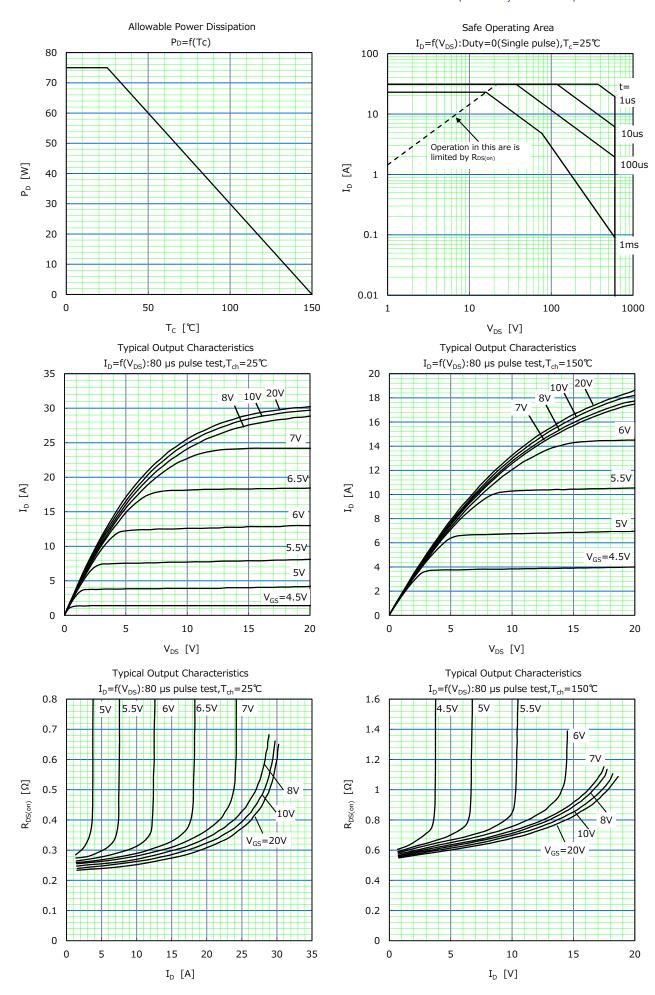
Note *6 : $C_{o(er)}$ is a fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 400V. Note *7 : $C_{o(tr)}$ is a fixed capacitance that gives the same charging times as C_{oss} while V_{DS} is rising from 0 to 400V.

Reverse Diode

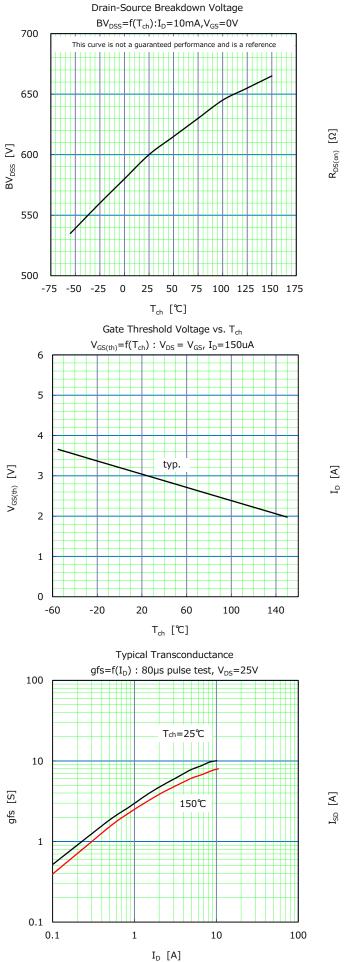
Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
Diode Forward On-Voltage	V _{SD}	I _{SD} =10.4A, V _{GS} =0V T _{ch} =25°C	-	0.95	1.35	V
Reverse Recovery Time	trr	- V₀₀=400V, I₅₀=10.4A -di/dt=100A/µs T₅h=25°C See Fig.6 and Fig.7	-	290	-	ns
Reverse Recovery Charge	Qrr		-	2.9	-	μC
Peak Reverse Recovery Current	Irp		-	20.5	-	А

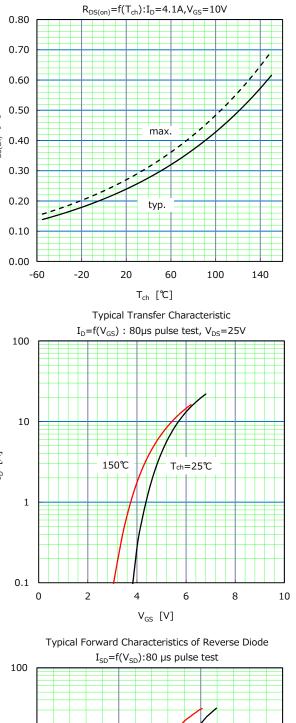
Thermal Resistance

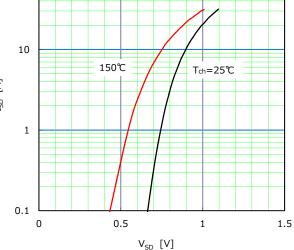
Parameter	Symbol	Min.	Тур.	Max.	Unit
Channel to Case	R _{th(ch-c)}	-	-	1.667	°C/W



Drain-Source On-state Resistance

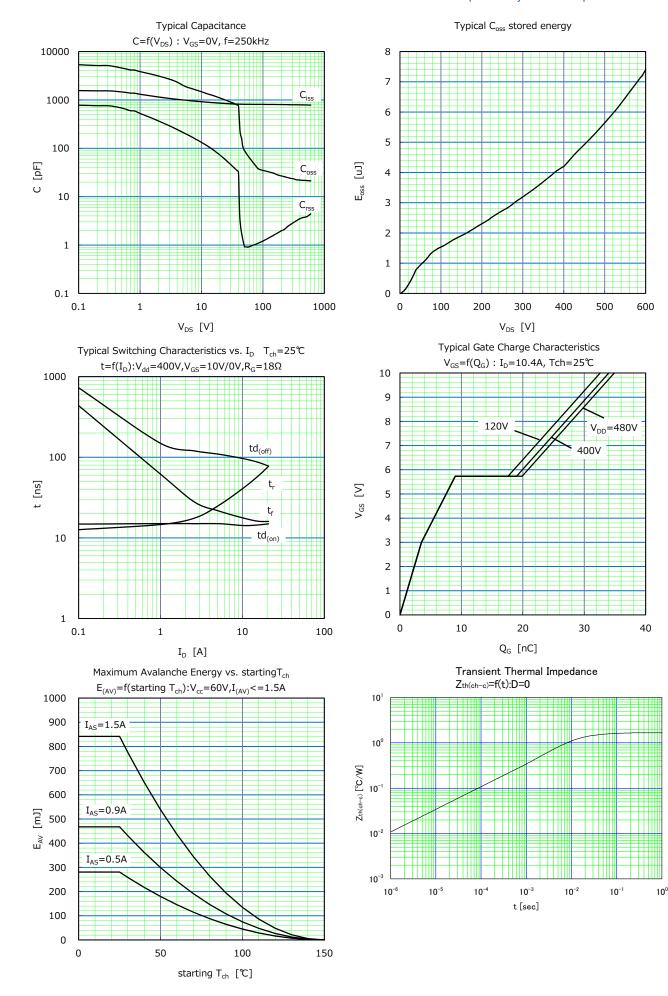






FMD60N280S2HF

http://www.fujielectric.com/products/semiconductor/



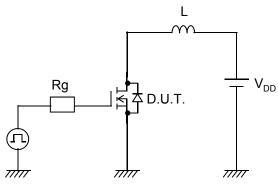


Fig.1 Avalanche Test circuit

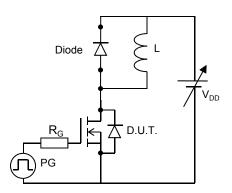


Fig.3 Switching Test circuit



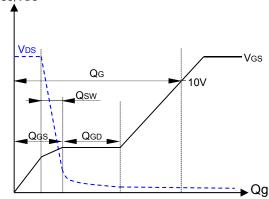
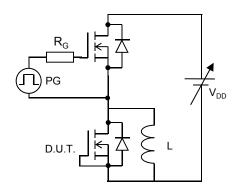
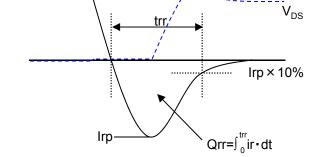


Fig.5 Operating waveform of Gate charge Test





 $V_{\text{DS peak}}$

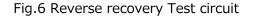


Fig.7 Operating waveform of Reverse recovery Test

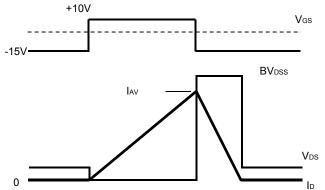


Fig.2 Operating waveforms of Avalanche Test

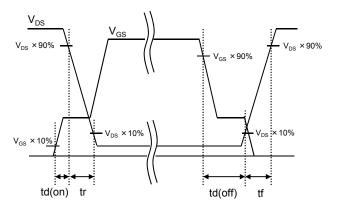
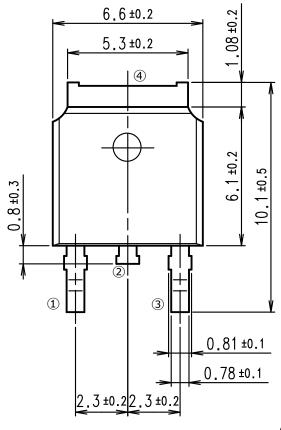
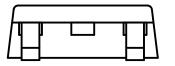


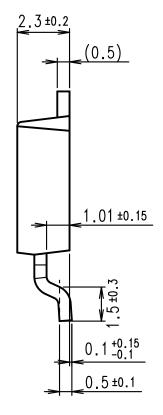
Fig.4 Operating waveform of Switching Test

ISD

Outview: TO-252 Package







CONNECTION

1 GATE

- 2 4 DRAIN
- ③ SOURCE

DIMENSIONS ARE IN MILLIMETERS

Notes

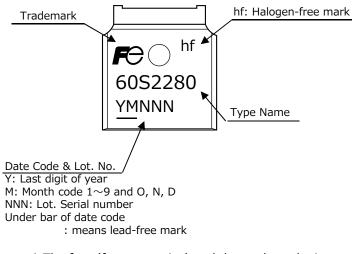
1.() : Reference dimensions.

2. The metal part is covered with the solder plating, part of cutting is without the solder plating.

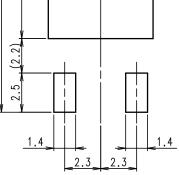
6.7

Recommended footprint

Marking



6.3 6.3



* The font (font type, size) and the trademark-size might be actually different.

WARNING

- 1. This Catalog contains the product specifications, characteristics, data, materials, and structures as of October 2016. The contents are subject to change without notice for specification changes or other reasons. When using a product listed in this Catalog, be sur to obtain the latest specifications. 2. All applications described in this Catalog exemplify the use of Fuji's products for your reference only. No right or license, either express or implied, under any patent, copyright, trade secret or other intellectual property right owned by Fuji Electric Co., Ltd. is (or shall be deemed) granted. Fuji Electric Co., Ltd. makes no representation or warranty, whether express or implied, relating to the infringement or alleged infringement of other's intellectual property rights which may arise from the use of the applications described herein. 3. Although Fuji Electric Co., Ltd. is enhancing product quality and reliability, a small percentage of semiconductor products may become faulty. When using Fuji Electric semiconductor products in your equipment, you are requested to take adequate safety measures to prevent the equipment from causing a physical injury, fire, or other problem if any of the products become faulty. It is recommended to make your design failsafe, flame retardant, and free of malfunction. 4. The products introduced in this Catalog are intended for use in the following electronic and electrical equipment which has normal reliability requirements. Computers OA equipment Communications equipment (terminal devices) Measurement equipment Electrical home appliances • Personal equipment • Industrial robots etc. Machine tools Audiovisual equipment 5. If you need to use a product in this Catalog for equipment requiring higher reliability than normal, such as for the equipment listed below, it is imperative to contact Fuji Electric Co., Ltd. to obtain prior approval. When using these products for such equipment, take adequate measures such as a backup system to prevent the equipment from malfunctioning even if a Fuji's product incorporated in the equipment becomes faulty. • Transportation equipment (mounted on cars and ships) Trunk communications equipment • Traffic-signal control equipment · Gas leakage detectors with an auto-shut-off feature · Emergency equipment for responding to disasters and anti-burglary devices · Safety devices Medical equipment 6. Do not use products in this Catalog for the equipment requiring strict reliability such as the following and equivalents to strategic equipment (without limitation). Space equipment · Aeronautic equipment Nuclear control equipment Submarine repeater equipment 7. Copyright ©1996-2016 by Fuji Electric Co., Ltd. All rights reserved. No part of this Catalog may be reproduced in any form or by any means without the express permission of Fuji Electric Co., Ltd. 8. If you have any question about any portion in this Catalog, ask Fuji Electric Co., Ltd. or its sales agents before using the product.
 - Neither Fuji Electric Co., Ltd. nor its agents shall be liable for any injury caused by any use of the products not in accordance with instructions set forth herein.